## $\square$ MN101C74F, MN101C74G

| Type | MN101C74F | MN101C74G | MN101CF74G |
| :---: | :---: | :---: | :---: |
| Internal ROM type | Mask ROM |  | FLASH |
| ROM (byte) | 96K | 128K |  |
| RAM (byte) | 6 K |  |  |
| Package (Lead-free) | LQFP100-P-1414, MLGA100-L-1010, QFP100-P-1818B |  |  |
| Minimum Instruction Execution Time | $\begin{gathered} 0.1 \mu \mathrm{~s} \text { (at } 3.0 \mathrm{~V} \text { to } 3.6 \mathrm{~V}, 10 \mathrm{MHz} \text { ) } \\ 0.235 \mu \mathrm{~s} \text { (at } 1.8 \mathrm{~V} \text { to } 3.6 \mathrm{~V}, 4.25 \mathrm{MHz})^{*} \\ 62.5 \mu \mathrm{~s} \text { (at } 1.8 \mathrm{~V} \text { to } 3.6 \mathrm{~V}, 32 \mathrm{kHz})^{*} \end{gathered}$ <br> operation guarantee for flash memory built-in type is 2.2 V . |  |  |

## Interrupts

RESET, Watchdog, External 0 to 5, External 6 (key interrupt dedicated), Timer 0 to 3, Timer 6, Timer 7 (2 systems), Timer 8 (2 systems), Time base, Serial 0 (2 systems), Serial 1 (2 systems), Serial 3, A/D conversion finish, Automatic transfer finish

## Timer Counter

Timer counter 0 : 8 -bit $\times 1$
(square-wave/8-bit PWM output, event count, generation of remote control carrier, simple pulse width measurement, added pluse (2-bit) system PWM output)
(square-wave/PWM output to large current terminal PC3 possible)
Clock source $\qquad$ $1 / 2,1 / 4$ of system clock frequency; $1 / 1,1 / 4,1 / 16,1 / 32,1 / 64$ of OSC oscillation clock frequency; $1 / 1$ of XI oscillation clock frequency; external clock input
Interrupt source $\qquad$ coincidence with compare register 0

Timer counter 1:8-bit $\times 1$ (square-wave output, event count, synchronous output event)
Clock source $\qquad$ $1 / 2,1 / 8$ of system clock frequency; $1 / 1,1 / 4,1 / 16,1 / 64,1 / 128$ of OSC oscillation clock frequency; $1 / 1$ of XI oscillation clock frequency; external clock input; timer counter 8 output
Interrupt source $\qquad$ coincidence with compare register 1

Timer counter 0, 1 can be cascade-connected.
Timer counter 2 : 8 -bit $\times 1$
(square-wave output, added pluse (2-bit) system PWM output, PWM output, serial transfer clock output, event count, synchronous output event, simple pulse width measurement)
(square-wave/PWM output to large current terminal PC5 possible)
$\qquad$ $1 / 2,1 / 4$ of system clock frequency; $1 / 1,1 / 4,1 / 16,1 / 32,1 / 64$ of OSC oscillation clock frequency; $1 / 1$ of XI oscillation clock frequency; external clock input
Interrupt source $\qquad$ coincidence with compare register 2

Timer counter 3 : 8-bit $\times 1$
(square-wave output, event count, generation of remote control carrier, serial transfer clock)
Clock source. $\qquad$ $1 / 2,1 / 8$ of system clock frequency; $1 / 1,1 / 4,1 / 16,1 / 64,1 / 128$ of OSC oscillation clock frequency; $1 / 1$ of XI oscillation clock frequency; external clock input
Interrupt source $\qquad$ coincidence with compare register 3

Timer counter 2, 3 can be cascade-connected.
Timer counter 6:8-bit freerun timer
Clock source. $\qquad$ $1 / 1$ of system clock frequency; $1 / 1,1 / 128,1 / 8192$ of OSC oscillation clock frequency; $1 / 1,1 / 128,1 / 8192$ of XI oscillation clock frequency
Interrupt source $\qquad$ coincidence with compare register 6

Timer counter 7 : 16 -bit $\times 1$
(square-wave output, 16-bit PWM output (cycle / duty continuous variable), event count, synchronous output event, pulse width measurement, input capture, real time output control, high performance IGBT output (Cycle/Duty can be changed constantly))
(square-wave/PWM output to large current terminal PC4 possible)
Clock source............... 1/1, 1/2, 1/4, 1/16 of system clock frequency; $1 / 1,1 / 2,1 / 4,1 / 16$ of OSC oscillation clock frequency; 1/1, $1 / 2,1 / 4,1 / 16$ of external clock input frequency
Interrupt source $\qquad$ coincidence with compare register 7 (2 lines), input capture register

Timer counter 8 : 16 bit $\times 1$
(square-wave/16-bit PWM output [duty continuous variable], event count, pulse width measurement, input capture) (square-wave/PWM output to large current terminal PC6 possible)

Clock source $\qquad$ $1 / 1,1 / 2,1 / 4,1 / 16$ of system clock frequency; $1 / 1,1 / 2,1 / 4,1 / 16$ of OSC oscillation clock frequency; $1 / 1$, $1 / 2,1 / 4,1 / 16$ of external clock input frequency
Interrupt source $\qquad$ coincidence with compare register 8 (2 lines), input capture register

Timer counters 7, 8 can be cascade-connected. (square-wave output, PWM is possible as a 32 -bit timer.)
Time base timer (one-minute count setting)
Clock source................ $1 / 1$ of OSC oscillation clock frequency; $1 / 1$ of XI oscillation clock frequency
Interrupt source .......... $1 / 128,1 / 256,1 / 512,1 / 1024,1 / 4096,1 / 8192,1 / 16384,1 / 32768$, of clock source frequency
Watchdog timer
Interrupt source .......... $1 / 65536,1 / 262144,1 / 1048576$ of system clock frequency

## - Serial interface

Serial 0 : synchronous type/UART (full-duplex) $\times 1$
Clock source $\qquad$ $1 / 2,1 / 4$ of system clock frequency; pulse output of timer counter 1 or $2 ; 1 / 2,1 / 4,1 / 16,1 / 64$ of OSC oscillation clock frequency, external clock

Serial 1 : synchronous type/UART (full-duplex) $\times 1$
Clock source $\qquad$ $1 / 2,1 / 4$ of system clock frequency; pulse output of timer counter 2 or $3 ; 1 / 2,1 / 4,1 / 16,1 / 64$ of OSC oscillation clock frequency, external clock

Serial 3 : synchronous type/single-master $I^{2} C \times 1$
Clock source $\qquad$ $1 / 2,1 / 4$ of system clock frequency; pulse output of timer counter 2 or $3 ; 1 / 2,1 / 4,1 / 16,1 / 32$ of OSC oscillation clock frequency, external clock

Serial 4 : $I^{2} \mathrm{C}$ slave $\times 1$ (Applicable for $I^{2} \mathrm{C}$ high-speed transfer mode, 7 -bit/ 10 -bit address setting, general call)

## DMA controller

Max. Transfer cycles 255
Starting factor external request, various types of interrupt, software
Transfer mode 1-byte transfer, word transfer, burst transfer

## I/O Pins

I/O
87
Common use, Specified pull-up resistor available, Input/output selectable (bit unit)

## - A/D converter

10 -bit $\times 16$-ch. (with $\mathrm{S} / \mathrm{H}$ )

## - Display control function

LCD
47 segments $\times 4$ commons (static, $1 / 2,1 / 3$, or $1 / 4$ duty)
LCD power supply separated from VDD (usable if VDD $\leq \mathrm{VLCD} \leq 3.6 \mathrm{~V}$ )
LCD power step-up circuit contained (3/2, 2 and 3 times)
LCD power shunt resistance contained

## - Special Ports

Buzzer output, remote control carrier signal output, high-current drive port

## ROM Correction

Correcting address designation : up to 7 addresses possible

Electrical Charactreistics (Supply current)

| Parameter | Symbol | Condition | Limit |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | min | typ | max |  |
| Operating supply current | IDD1 | fosc $=4 \mathrm{MHz}, \mathrm{VDD}=3 \mathrm{~V}$ |  | 1.1 | 1.9 | mA |
|  | IDD2 | $\mathrm{fx}=32 \mathrm{kHz}, \mathrm{VDD}=3 \mathrm{~V}$ |  | 6 | 20 | $\mu \mathrm{A}$ |
| Supply current at HALT | IDD3 | $\mathrm{fx}=32 \mathrm{kHz}, \mathrm{VDD}=3 \mathrm{~V}, \mathrm{Ta}=25^{\circ} \mathrm{C}$ |  | 3 | 6 | $\mu \mathrm{A}$ |
|  | IDD4 | $\mathrm{fx}=32 \mathrm{kHz}, \mathrm{VDD}=3 \mathrm{~V}, \mathrm{Ta}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 13 | $\mu \mathrm{A}$ |
| Supply current at STOP | IDD5 | $\mathrm{VDD}=3 \mathrm{~V}, \mathrm{Ta}=25^{\circ} \mathrm{C}$ |  |  | 2 | $\mu \mathrm{A}$ |
|  | IDD6 | VDD $=3 \mathrm{~V}, \mathrm{Ta}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 10 | $\mu \mathrm{A}$ |

## Development tools

In-circuit Emulator
PX-ICE101C/D+PX-PRB101C74-QFP100-P-1818B-M
PX-ICE101C/D+PX-PRB101C74-LQFP100-P-1414-M

## Pin Assignment



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